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Requirement

Indian Standard



SPECIFICATION FOR QUARTZ CRYSTAL UNITS USED FOR FREQUENCY CONTROL AND SELECTION

PART III SERIES BC FOR OSCILLATORS

Section 4 Quartz Crystal Unit Type BC-04

- 0. General This standard shall be read in conjunction with IS: 8271 (Part I)-1981 'Specification for quartz crystal units used for frequency control and selection: Part I General requirements and tests (first revision)'.
- 1. Outline and Dimensions Holder outline shall conform to Type BC (see Sheet No. 5 of IS: 4570-1968 Specification for crystal holders).
- 2. Marking See 8 of IS: 8271 (Part I)-1981.
- 3. Construction and Workmanship See 7 of IS: 8271 (Part 1)-1981.
- 4. Test Schedule and Detail Requirements

SI No.

4.1 General Conditions for Test — See 9.2 of IS: 8271 (Part I)-1981.

Characteristic

- 4.2 Test Schedule The sequence and grouping of type, routine and acceptance tests shall be as per 9.1 of IS: 8271 (Part I)-1981.
- 4.3 Detail Requirements The detail requirements applicable to this particular type of crystal unit shall be as specified in Table 1.

TABLE 1 DETAIL REQUIREMENTS OF QUARTZ CRYSTAL UNIT TYPE BC-04

21 MO:	Clintac	ratistic	vadanem		
(1)	(1) (2)		(8)		
I)	Type of helder		BC (See 1)		
ii)	Frequency rang	9	5 to 20 MHz		
III)	Frequency toler	ance:			
	a) Over oper	erating temperature:	± 25 ppm		
iv)	Resonance resi	stance	See Table 2		
v)	Mode of oscilla	tion	Fundamental +		
vI)	Load capacitan	се	30 ± 0.5 pF		
vii)	Capacitance st	nunt	7 pF Max		
viii)	Operating temp	erature range	-20°C to +70°C		
ix)	Test set, calib	ration values and vel	See Table 8		
x) Shock [as per 9.15 (Severity A of IS: 8271 (Part I) - 1981]:		r 9.15 (Severity A) Part I) - 1981]:			
	a) Frequenc	y change permitted	± 5 ppm		
	b) Resonand permitted	ce resistance change	± 10 percent		
			(Continued)		
Adopted 21 May 1982		September 1982, ISI	Gr 1		

TABLE 1	DETAIL	REQUIREMENTS	OF	OUARTZ	CRYSTAL	UNIT	TYPE	BC-04 - Conto	ı
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SI No.	Characteristic	Requirement
(1)	(2)	(3)
xi)	Vibration [as per 9.16.1 (Severity A) of IS : 8271 (Part I)-1981]:	
	a) Frequency change permitted	±5 ppm
	b) Resonance resistance change permitted	± 10 percent
xii)	Temperature cycling:	
	a) Frequency change permitted	± 5 ppm
	 b) Resonance resistance change permitted 	± 10 percent
xiii)	Temperature run:	
	a) Frequency change permitted	± 5 ppm
	 Resonance resistance change permitted 	± 10 percent
xiv)	Ageing Frequency change permitted	5 ppm

TABLE 2 RESONANCE RESISTANCE

[Table 1, Item (iv)]

Frequency ⁻ Range MHz	Maximum Resonance Resistance Ohms
(1)	(2)
From 5 to 6	75
Over 6 to 7	50
Over 7 to 10	30
Over 10 to 20	25

TABLE 3 TEST SET, CALIBRATION VALUES AND RATED DRIVE LEVEL

[Table 1, Item (ix)]

SI No.	Frequency Range	Cai	Rated Drive Level		
		Resistance	Crystal Current	Resistor Voltage Drop	FGAGI
	MHz	Ohms	m A	v ·	mW
(1)	(2)	(3)	(4)	(5)	(6)
i)	From 5 to 7:5	25	14		7
ii)	Over 7.5 to 10	16	18	**Auritan	F-0 1 4-0
iii)	Over 10 to 15	13	20		5·0 ± 1·0
lv)	Over 15 to 20	12		0.24	}
	For SI No. (i) to (iii) — T For SI No. (iv) — Test S	•	1.		